,	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/824,582	BOEHM ET AL.	
Examiner	Art Unit	
Jamara A. Franklin	2876	

SEARCHED			
Class	Subclass	Date	Examiner
235	462.01- 462.49	9/27/2006	JAF
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
235/462.01-462.49 (text search only)	9/27/2006	JAF
consulted Michael G. Lee (class 235)		
consulted Clayton LaBalle (SPRE)		
consulted Hein Phan (SPRE)	\	\bigcup